



Data Sheet

π 220N31/ π 221N31

FEATURES

- Bidirectional I²C communication
- Ultra-low power consumption
- Supports up to 2 MHz operation
- Open-drain interfaces
 - Side 1 outputs with 3.5 mA sink current
 - Side 2 outputs with 35 mA sink current
- 3.0V to 5.5V supply/logic levels
- High common-mode transient immunity: 75 kV/ μ s typical
- Safety and regulatory approvals(Pending):
 - UL recognition:
 - 3000Vrms for 1 minute per UL 1577
 - CSA Component Acceptance Notice 5A
 - VDE certificate of conformity:
 - DIN V VDE V 0884-10 (VDE V 0884-10):2006-12
 - V_{IORM} = 707V peak
 - CQC certification per GB4943.1-2011
 - AEC-Q100 (Pending)
 - Wide temperature range: -40°C to 125°C
- 8-lead, RoHS-compliant, SOIC package

APPLICATIONS

- Isolated I²C, SMBus, PMBus interfaces
- Multilevel I²C interfaces
- Electric and Hybrid-Electric Vehicles
- Open-Drain Networks
- I²C Level Shifting
- Power supplies

GENERAL DESCRIPTION

The π 220N31/ π 221N31 devices are low-power bidirectional isolators compatible with the I²C interface and are based on **iDivider** technology from 2PaiSemi. These devices have logic input and output buffers that are separated by using a silicon dioxide (SiO₂) barrier. These devices block high voltages and prevent noise currents from entering the control side ground, avoiding circuit interference and damaging sensitive components.

The π 220N31/ π 221N31 devices are based on iDivider technology with functional, performance, size, and power consumption advantages as compared to optocouplers.

The π 220N31 provides two bidirectional channels, supporting a complete isolated I²C interface. The π 221N31 provides one bidirectional channel and one unidirectional channel for applica-

tions where a bidirectional clock is not required. The π 221N31 is used in applications that have a single master while the π 220N31 is suitable for multi-master applications.

These devices feature independent 3.0V to 5.5V supplies on each side of the isolator. These devices operate from DC to 2MHz at ambient temperatures of -40°C to +125°C.

FUNCTIONAL BLOCK DIAGRAMS

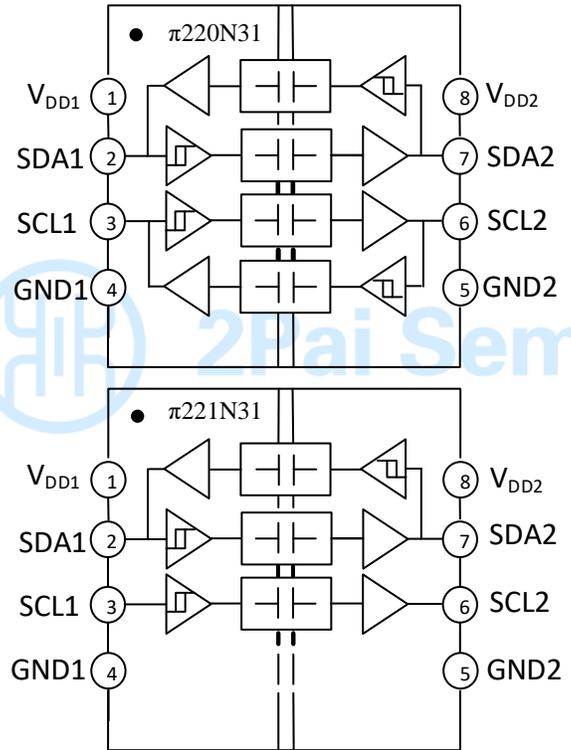


Figure1. π 220N31/ π 221N31 functional Block Diagram

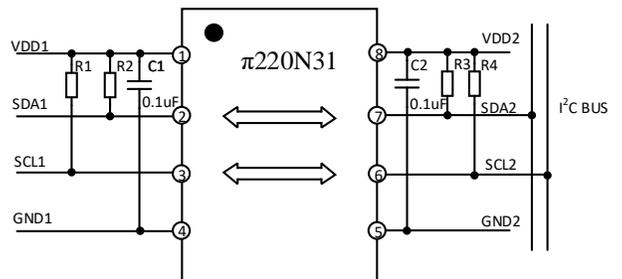


Figure2. π 220N31 Typical Application Circuit

Rev.1

Information furnished by 2Pai semi is believed to be accurate and reliable. However, no responsibility is assumed by 2Pai semi for its use, nor for any infringements of patents or other rights of third parties that may result from its use. Specifications subject to change without notice. No license is granted by implication or otherwise under any patent or patent rights of 2Pai semi.

Trademarks and registered trademarks are the property of their respective owners.

Room 308-309, No.22, Boxia Road, Pudong New District, Shanghai, 201203, China
021-50850681
2Pai Semiconductor Co., Limited. All rights reserved.
<http://www.rpsemi.com/>

PIN CONFIGURATIONS AND FUNCTIONS

π 220N31/ π 221N31 Pin Function Descriptions

Pin No.	Name	Description
1	VDD1	Supply Voltage for Isolator Side 1.
2	SDA1	Serial data input / output, side 1.
3	SCL1	Serial clock input / output, side 1.
4	GND ₁	Ground 1. This pin is the ground reference for Isolator Side 1.
5	GND ₂	Ground 2. This pin is the ground reference for Isolator Side 2.
6	SCL2	Serial clock input / output, side 2.
7	SDA2	Serial data input / output, side 2.
8	VDD2	Supply Voltage for Isolator Side 2.

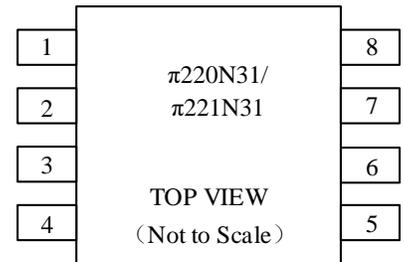


Figure 3. π 220N31/ π 221N31 Pin Configuration

ABSOLUTE MAXIMUM RATINGS

Table 1. Absolute Maximum Ratings^{1,2}

Parameter	Rating
Supply Voltages (V _{DD1} -GND ₁ , V _{DD2} -GND ₂)	-0.5 V to +7.0 V
Signal Voltage SDA1/SCL1	-0.5 V to V _{DDx} + 0.5 V
Signal Voltage SDA2/SCL2	-0.5 V to V _{DDx} + 0.5 V
Average Output Current SDA1/SCL1 (I _{O1})	-20 mA to +20 mA
Average Output Current SDA2/SCL2 (I _{O2})	-100 mA to +100 mA
Storage Temperature (T _{ST}) Range	-55°C to +150°C
Maximum junction temperature T _{J(MAX)}	+150°C

Notes:

¹ All voltage values here within are with respect to the local ground pin (GND1 or GND2) and are peak voltage values.

² Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

RECOMMENDED OPERATING CONDITIONS

Table 2. Recommended Operating Conditions

Parameter	Symbol	Min	Typ	Max	Unit
Supply Voltage	V _{DDx} ¹	3		5.5	V
Input/Output Signal Voltage (V _{SDA1} , V _{SCL1} , V _{SDA2} , V _{SCL2})		0		V _{DDx} ¹	V
Low-level input voltage, side 1	V _{IL1}	0		0.45	V
High-level input voltage, side 1	V _{IH1}	0.7*V _{DD1}		V _{DD1}	V
Low-level input voltage, side 2	V _{IL2}	0		0.3*V _{DD2}	V
High-level input voltage, side 2	V _{IH2}	0.7*V _{DD2}		V _{DD2}	V
Output current, side 1	I _{OL1}	0.5		3.5	mA
Output current, side 2	I _{OL2}	0.5		35	mA
Capacitive load, side 1	C1			40	pF
Capacitive load, side 2	C2			400	pF
Operating frequency	f _{MAX}			2	MHz
Ambient Operating Temperature	T _A	-40		125	°C

Notes:

¹ V_{DDx} is the side voltage power supply V_{DD}, where x = 1 or 2.

Truth Tables

Table 3. $\pi 220N31/\pi 221N31$ Truth Table

V_{ix} Input ¹	V_{DDi} State ¹	V_{DDO} State ¹	V_{Ox} Output ¹
Low	Powered ²	Powered ²	Low
High	Powered ²	Powered ²	High Impedance
Open ⁴	Powered ²	Powered ²	High Impedance
Don't Care	Unpowered ³	Powered ²	High Impedance
Don't Care	Powered ²	Unpowered ³	High Impedance

Notes:

¹ V_{ix}/V_{Ox} are the input/output signals of a given channel (SDA or SCL). V_{DDi}/V_{DDO} are the supply voltages on the input/output signal sides of this given channel.² Powered means $V_{DDx} \geq 2.95$ V³ Unpowered means $V_{DDx} < 2.3$ V⁴ Invalid input condition as an I²C system requires that a pullup resistor to V_{DD} is connected.

SPECIFICATIONS

ELECTRICAL CHARACTERISTICS

Table 4. DC Specifications

 $V_{DD1} - V_{GND1} = V_{DD2} - V_{GND2} = 3.3V_{DC} \pm 10\%$ or $5V_{DC} \pm 10\%$, $T_A = 25^\circ\text{C}$, unless otherwise noted.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
SIDE 1 LOGIC LEVELS						
Voltage input threshold low, SDA1 and SCL1	V_{ILT1}	470	510	570	mV	
Voltage input threshold high, SDA1 and SCL1	V_{IHT1}	540	580	630	mV	
Voltage input hysteresis	V_{HYST1}	50	70		mV	$V_{IHT1} - V_{ILT1}$
Low-level output voltage, SDA1 and SCL1	V_{OL1}	650	700	800	mV	$0.5 \text{ mA} \leq (I_{SDA1} \text{ and } I_{SCL1}) \leq 3.5 \text{ mA}$
Low-level output voltage to high-level input voltage threshold difference, SDA1 and SCL1	ΔV_{OIT1}^1	60			mV	$0.5 \text{ mA} \leq (I_{SDA1} \text{ and } I_{SCL1}) \leq 3.5 \text{ mA}$
SIDE 2 LOGIC LEVELS						
Voltage input threshold low, SDA2 and SCL2	V_{ILT2}	$0.30 * V_{DD2}$		$0.42 * V_{DD2}$	V	
Voltage input threshold high, SDA2 and SCL2	V_{IHT2}	$0.60 * V_{DD2}$		$0.66 * V_{DD2}$	V	
Voltage input hysteresis	V_{HYST2}	$0.20 * V_{DD2}$			V	$V_{IHT2} - V_{ILT2}$
Low-level output voltage, SDA2 and SCL2	V_{OL2}			0.4	V	$0.5 \text{ mA} \leq (I_{SDA2} \text{ and } I_{SCL2}) \leq 35 \text{ mA}$
BOTH SIDES						
Input leakage currents, SDA1, SCL1, SDA2, and SCL2	$ I_{IN} $	0.01		10	μA	$V_{SDA1}, V_{SCL1} = V_{DD1}; V_{SDA2}, V_{SCL2} = V_{DD2}$
V_{DDx}^3 Undervoltage Rising Threshold	V_{DDxUV+}	2.45	2.8	2.95	V	
V_{DDx}^3 Undervoltage Falling Threshold	V_{DDxUV-}	2.3	2.65	2.8	V	
V_{DDx}^3 Hysteresis	V_{DDxUVH}	0.15			V	

Notes:

¹ $\Delta V_{OIT1} = V_{OL1} - V_{IHT1}$. This is the minimum difference between the output logic low level and the input logic threshold within a given component. This ensures that there is no possibility of the part latching up the bus to which it is connected.² V_{DDx} is the side voltage power supply V_{DD} , where $x = 1$ or 2 .

Table 5. Quiescent Supply Current

$V_{DD1} - V_{GND1} = V_{DD2} - V_{GND2} = 3.3V_{DC} \pm 10\%$ or $5V_{DC} \pm 10\%$, $T_A = 25^\circ C$, R1, R2 = Open; C1, C2 = Open (figure 17), unless otherwise noted. Test method refer to Figure 17.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions
$\pi 220N31$ Quiescent Supply Current @ $5V_{DC}$ Supply	$I_{DD1(Q)}$		1.7	2.4	mA	VSDA1, VSCL1 = GND1; VSDA2, VSCL2 = GND2
	$I_{DD2(Q)}$		1.4	2.1	mA	
	$I_{DD1(Q)}$		1.5	2.3	mA	VSDA1, VSCL1 = VDD1; VSDA2, VSCL2 = VDD2
	$I_{DD2(Q)}$		1.2	1.8	mA	
$\pi 220N31$ Quiescent Supply Current @ $3.3V_{DC}$ Supply	$I_{DD1(Q)}$		1.5	2.3	mA	VSDA1, VSCL1 = GND1; VSDA2, VSCL2 = GND2
	$I_{DD2(Q)}$		1.2	1.8	mA	
	$I_{DD1(Q)}$		1.5	2.3	mA	VSDA1, VSCL1 = VDD1; VSDA2, VSCL2 = VDD2
	$I_{DD2(Q)}$		1.2	1.8	mA	
$\pi 221N31$ Quiescent Supply Current @ $5V_{DC}$ Supply	$I_{DD1(Q)}$		1.1	1.7	mA	VSDA1, VSCL1 = GND1; VSDA2, VSCL2 = GND2
	$I_{DD2(Q)}$		1.2	1.8	mA	
	$I_{DD1(Q)}$		1.2	1.8	mA	VSDA1, VSCL1 = VDD1; VSDA2, VSCL2 = VDD2
	$I_{DD2(Q)}$		1.2	1.8	mA	
$\pi 221N31$ Quiescent Supply Current @ $3.3V_{DC}$ Supply	$I_{DD1(Q)}$		1.0	1.5	mA	VSDA1, VSCL1 = GND1; VSDA2, VSCL2 = GND2
	$I_{DD2(Q)}$		1.1	1.7	mA	
	$I_{DD1(Q)}$		1.1	1.7	mA	VSDA1, VSCL1 = VDD1; VSDA2, VSCL2 = VDD2
	$I_{DD2(Q)}$		1.1	1.7	mA	

Table 6. Switching Specifications

$V_{DD1} - V_{GND1} = V_{DD2} - V_{GND2} = 3.3V_{DC} \pm 10\%$ or $5V_{DC} \pm 10\%$, $T_A = 25^\circ C$, unless otherwise noted. Test method refer to Figure 17.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
Output Signal Fall Time SDA1, SCL1	t_{f1}	10	18	30	ns	0.9 V_{DD1} to 0.9 V; R1 = 1430 Ω , C1 = 40 pF, @ 5V _{DC} supply
		9	16	28	ns	R1 = 953 Ω , C1 = 40 pF; @ 3.3V _{DC} supply
		6	11	18	ns	0.7 V_{DD1} to 0.3 V_{DD1} ; R1 = 1430 Ω , C1 = 40 pF, @ 5V _{DC} supply
		6	10	16	ns	R1 = 953 Ω , C1 = 40 pF; @ 3.3V _{DC} supply
Output Signal Fall Time (SDA2, SCL2)	t_{f2}	22	36	45	ns	0.9 V_{DD2} to 0.4V; R2 = 143 Ω , C2 = 400 pF, @ 5V _{DC} supply
		20	31	42	ns	R2 = 95.3 Ω , C2 = 400 pF; @ 3.3V _{DC} supply
		9	16	26	ns	0.7 V_{DD2} to 0.3 V_{DD2} ; R2 = 143 Ω , C2 = 400 pF, @ 5V _{DC} supply
		8	14	23	ns	R2 = 95.3 Ω , C2 = 400 pF; @ 3.3V _{DC} supply
Low-to-High Propagation Delay, Side 1 to Side 2	t_{pLH1-2}	45	68	ns	0.55 V to 0.7 $\times V_{DD2}$; R1 = 1430 Ω , R2 = 143 Ω , C1, C2 = 10 pF; @ 5V _{DC} supply	
		38	57	ns	R1 = 953 Ω , R2 = 95.3 Ω , C1, C2 = 10 pF; @ 3.3V _{DC} supply	
High-to-Low Propagation Delay, Side 1 to Side 2	t_{pHL1-2}	67	100	ns	0.7 V to 0.4 V; R1 = 1430 Ω , R2 = 143 Ω , C1, C2 = 10 pF; @ 5V _{DC} supply	
		64	96	ns	R1 = 953 Ω , R2 = 95.3 Ω , C1, C2 = 10 pF; @ 3.3V _{DC} supply	
Pulse Width Distortion $t_{pHL1-2} - t_{pLH1-2}$	PWD1-2	22	32	ns	R1 = 1430 Ω , R2 = 143 Ω , C1, C2 = 10 pF; @ 5V _{DC} supply	
		26	39	ns	R1 = 953 Ω , R2 = 95.3 Ω , C1, C2 = 10 pF; @ 3.3V _{DC} supply	

Low-to-High Propagation Delay, Side 2 to Side 1	tPLH2-1	44	62	ns	0.4 × V _{DD2} to 0.7 × V _{DD1} ; R1 = 1430 Ω, R2 = 143 Ω, C1, C2 = 10 pF; @ 5V _{DC} supply
		42	56	ns	
High-to-Low Propagation Delay, Side 2 to Side 1	tPHL2-1	52	78	ns	0.4 × V _{DD2} to 0.9 V; R1 = 1430 Ω, R2 = 143 Ω, C1, C2 = 10 pF; @ 5V _{DC} supply
		57	86	ns	
Pulse Width Distortion t _{PHL2-1} – t _{PLH2-1}	PWD2-1	8	16	ns	R1 = 953 Ω, R2 = 95.3 Ω, C1, C2 = 10 pF; @ 3.3V _{DC} supply
		15	30	ns	
Round-trip propagation delay on Side 1	tLOOP1	104	156	ns	0.4 V to 0.3 × V _{DD1} ; R1 = 1430 Ω, R2 = 143 Ω, C1, C2 = 10 pF; @ 5V _{DC} supply
		88	132	ns	
Common-Mode Transient Immunity ²	CMTI	40	75	kV/μs	V _{IN} = V _{DDx} ¹ or 0V, V _{CM} = 1000 V.
ESD (HBM - Human body model)	ESD	±4	±6	kV	all pins

Notes:

¹ V_{DDx} is the side voltage power supply V_{DD}, where x = 1 or 2.² See Figure 21 for Common-mode transient immunity (CMTI) measurement.

INSULATION AND SAFETY RELATED SPECIFICATIONS

Table 7. Insulation Specifications

Parameter	Symbol	Value	Unit	Test Conditions/Comments
		$\pi 220N31/\pi 221N31$		
Rated Dielectric Insulation Voltage		3000	V rms	1-minute duration
Minimum External Air Gap (Clearance)	L (CLR)	4	mm min	Measured from input terminals to output terminals, shortest distance through air
Minimum External Tracking (Creepage)	L (CRP)	4	mm min	Measured from input terminals to output terminals, shortest distance path along body
Minimum Clearance in the Plane of the Printed Circuit Board (PCB Clearance)	L (PCB)	4.5	mm min	Measured from input terminals to output terminals, shortest distance through air, line of sight, in the PCB mounting plane
Minimum Internal Gap (Internal Clearance)		21	μm min	Insulation distance through insulation
Tracking Resistance (Comparative Tracking Index)	CTI	>600	V	DIN IEC 112/VDE 0303 Part 1
Material Group		I		Material Group (DIN VDE 0110, 1/89, Table 1)

PACKAGE CHARACTERISTICS

Table 8. Package Characteristics

Parameter	Symbol	Typical Value	Unit	Test Conditions/Comments
		$\pi 220N31/\pi 221N31$		
Resistance (Input to Output) ¹	R _{I-O}	10 ¹¹	Ω	
Capacitance (Input to Output) ¹	C _{I-O}	1.5	pF	@1MHz
Input Capacitance ²	C _I	7	pF	@1MHz
IC Junction to Ambient Thermal Resistance	θ _{JA}	100	°C/W	Thermocouple located at center of package underside

Notes:

¹The device is considered a 2-terminal device; SOIC-8 Pin 1 - Pin 4 are shorted together as the one terminal, and SOIC-8 Pin 5 - Pin 8 are shorted together as the other terminal.

²Testing from the input signal pin to ground.

REGULATORY INFORMATION

See Table 9 for details regarding recommended maximum working voltages for specific cross isolation waveforms and insulation levels.

Table 9. Regulatory

UL (Pending)	CSA (Pending)	VDE (Pending)	CQC (Pending)
Recognized under UL 1577 Component Recognition Program ¹	Approved under CSA Component Acceptance Notice 5A	DIN V VDE V 0884-10 (VDE V 0884-10):2006-12 ²	Certified under CQC11-471543-2012
Single Protection, 3000 V rms Isolation Voltage	CSA 60950-1-07+A1+A2 and IEC 60950-1, second edition, +A1+A2: Basic insulation at 500 V rms (707 V peak)	Basic insulation, $V_{IORM} = 707$ V peak, $V_{IOSM} = 4615$ V peak	GB4943.1-2011 Basic insulation at 500 V rms (707 V peak) working voltage Reinforced insulation at 250 V rms (354 V peak)
File (pending)	File (pending)	File (pending)	File (pending)

Notes:

¹In accordance with UL 1577, each $\pi 220N31/\pi 221N31$ is proof tested by applying an insulation test voltage ≥ 3600 V rms for 1 sec.

²In accordance with DIN V VDE V 0884-10, each $\pi 220N31/\pi 221N31$ is proof tested by applying an insulation test voltage ≥ 1326 V peak for 1 sec (partial discharge detection limit = 5 pC). The * marking branded on the component designates DIN V VDE V 0884-10 approval.

DIN V VDE V 0884-10 (VDE V 0884-10) INSULATION CHARACTERISTICS

These isolators are suitable for reinforced electrical isolation only within the safety limit data. Protective circuits ensure the maintenance of the safety data. The * marking on packages denotes DIN V VDE V 0884-10 approval.

Table 10. VDE Insulation Characteristics

Description	Test Conditions/Comments	Symbol	Characteristic	Unit
			$\pi 220N31/\pi 221N31$	
Installation Classification per DIN VDE 0110				
For Rated Mains Voltage ≤ 150 V rms			I to IV	
For Rated Mains Voltage ≤ 300 V rms			I to III	
For Rated Mains Voltage ≤ 400 V rms			I to III	
Climatic Classification			40/105/21	
Pollution Degree per DIN VDE 0110, Table 1			2	
Maximum Working Insulation Voltage		V_{IORM}	707	V peak
Input to Output Test Voltage, Method B1	$V_{IORM} \times 1.875 = V_{pd(m)}$, 100% production test, $t_{ini} = t_m = 1$ sec, partial discharge < 5 pC	$V_{pd(m)}$	1326	V peak
Input to Output Test Voltage, Method A				
After Environmental Tests Subgroup 1	$V_{IORM} \times 1.5 = V_{pd(m)}$, $t_{ini} = 60$ sec, $t_m = 10$ sec, partial discharge < 5 pC	$V_{pd(m)}$	1061	V peak
After Input and/or Safety Test Subgroup 2 and Subgroup 3	$V_{IORM} \times 1.2 = V_{pd(m)}$, $t_{ini} = 60$ sec, $t_m = 10$ sec, partial discharge < 5 pC		849	V peak
Highest Allowable Overvoltage		V_{IOTM}	4200	V peak
Surge Isolation Voltage Basic	Basic insulation, 1.2 μ s rise time, 50 μ s, 50% fall time	V_{IOSM}	4615	V peak

Surge Isolation Voltage Reinforced	Reinforced insulation, 1.2 μ s rise time, 50 μ s, 50% fall time	V_{IOSM}		V peak
Safety Limiting Values	Maximum value allowed in the event of a failure (see Figure 4)			
Maximum Junction Temperature		T_S	150	$^{\circ}C$
Total Power Dissipation at 25 $^{\circ}C$		P_S	1.25	W
Insulation Resistance at T_S	$V_{IO} = 800$ V	R_S	$>10^9$	Ω

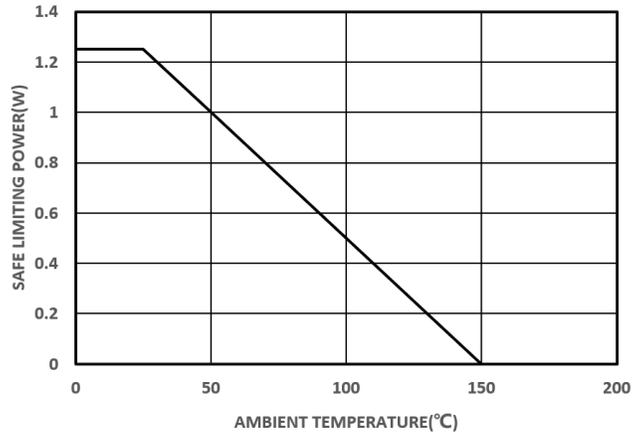


Figure 4. Thermal Derating Curve, Dependence of Safety Limiting Values with Ambient Temperature per VDE



TYPICAL CHARACTERISTICS

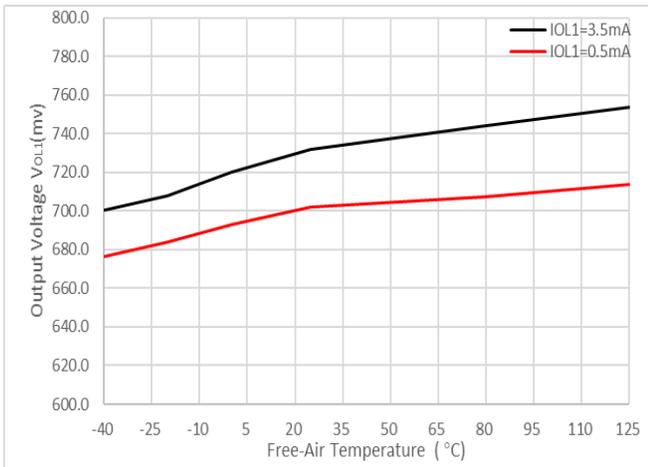


Figure 5. Side 1: Output Low Voltage vs Free-Air Temperature

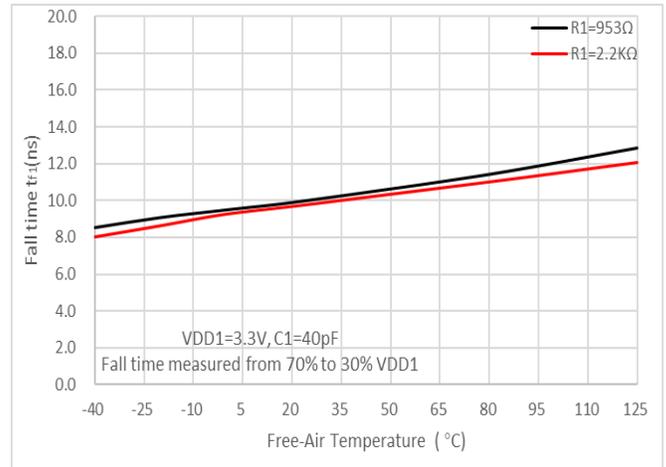


Figure 6. Side 1: Output Fall Time vs Free-Air Temperature

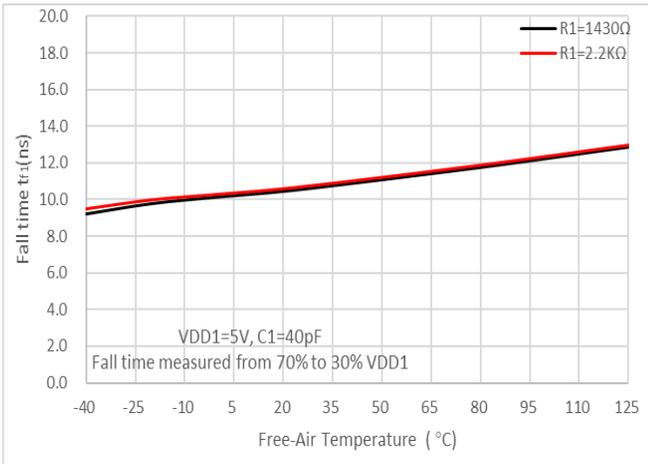


Figure 7. Side 1: Output Fall Time vs Free-Air Temperature

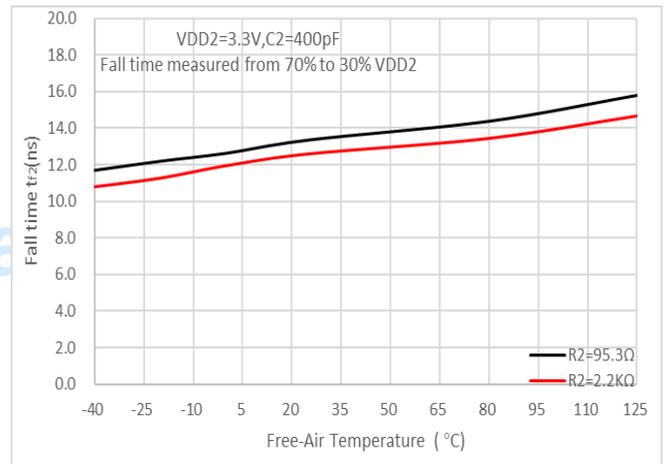


Figure 8. Side 2: Output Fall Time vs Free-Air Temperature

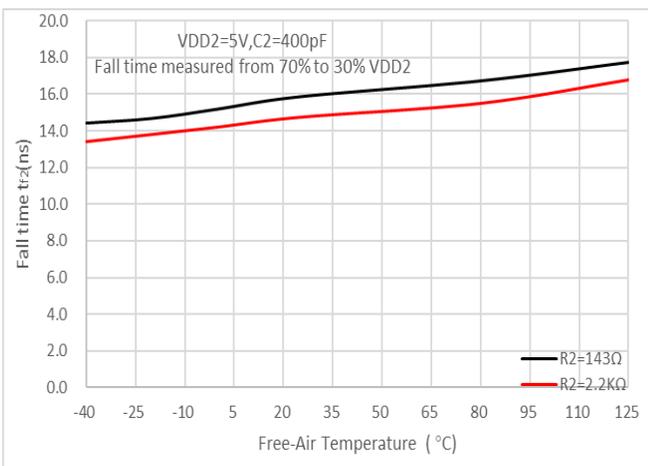


Figure 9. Side 2: Output Fall Time vs Free-Air Temperature

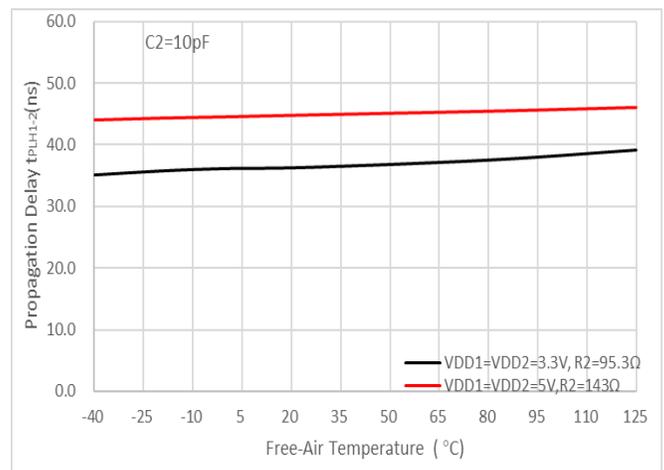


Figure 10. t_{PLH1-2} Propagation Delay vs Free-Air Temperature

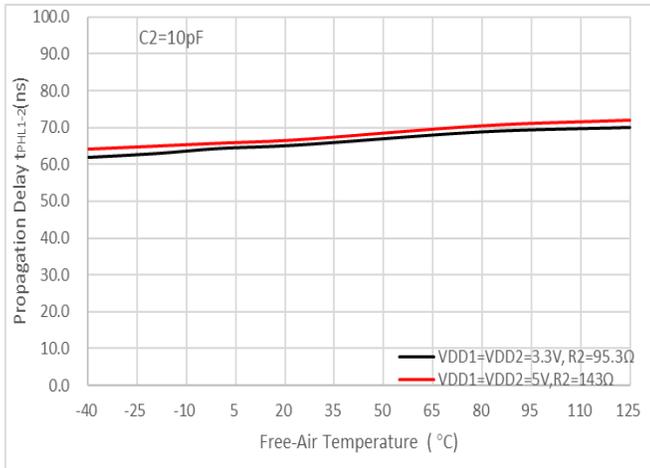


Figure 11. t_{PHL1-2} Propagation Delay vs Free-Air Temperature

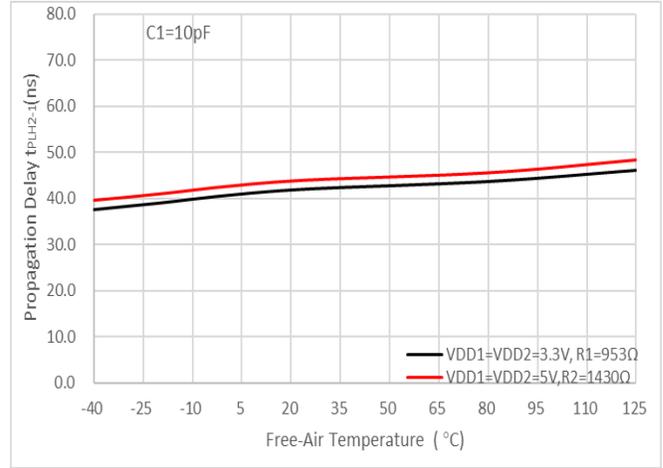


Figure 12. t_{PLH1-2} Propagation Delay vs Free-Air Temperature

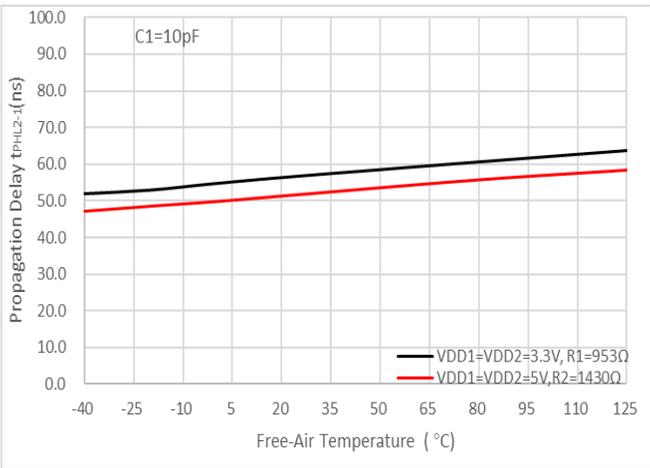


Figure 13. t_{PHL2-1} Propagation Delay vs Free-Air Temperature

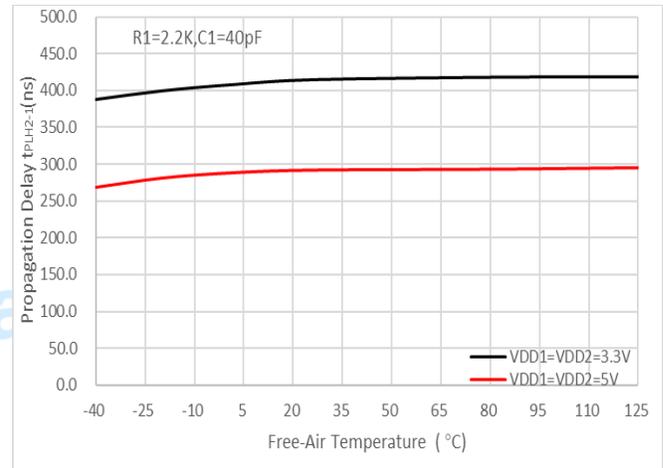


Figure 14. t_{PLH2-1} Propagation Delay vs Free-Air Temperature

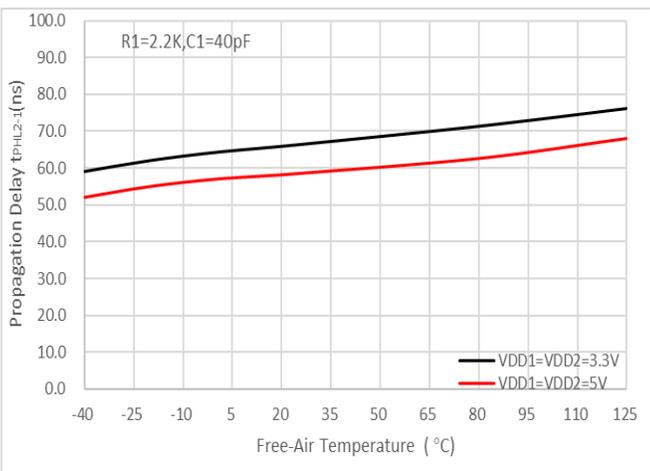


Figure 15. t_{PHL2-2} Propagation Delay vs Free-Air Temperature

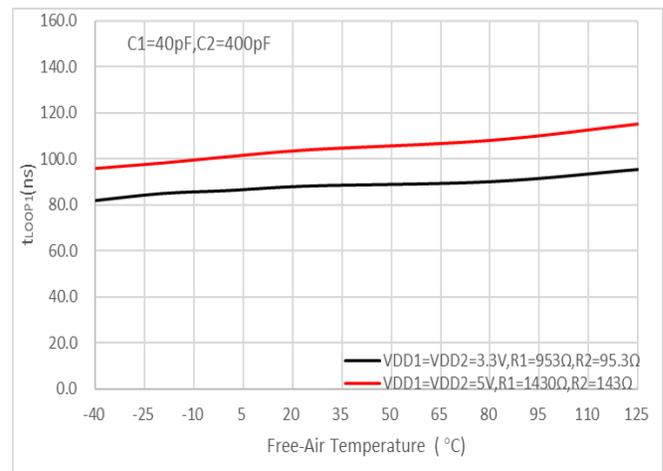


Figure 16. t_{LOOP1} vs Free-Air Temperature

PARAMETER MEASUREMENT INFORMATION

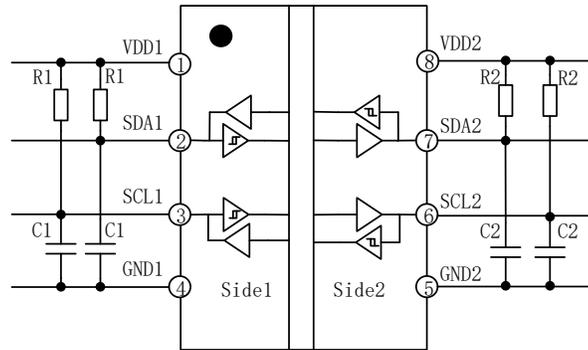


Figure 17. Test Diagram

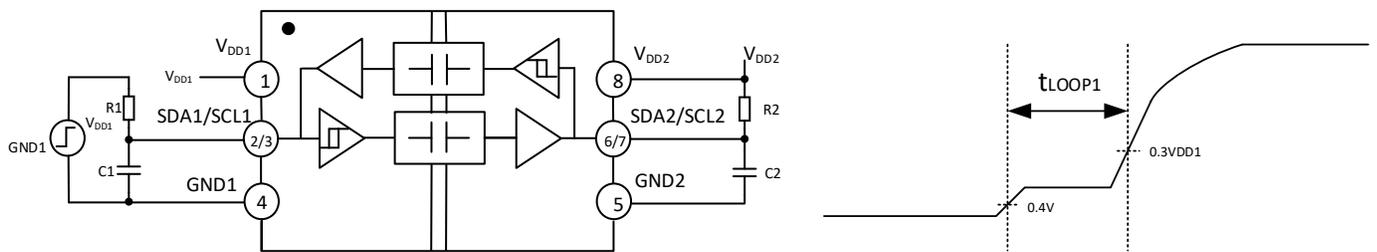


Figure 18. t_{loop1} Setup and Timing Diagram

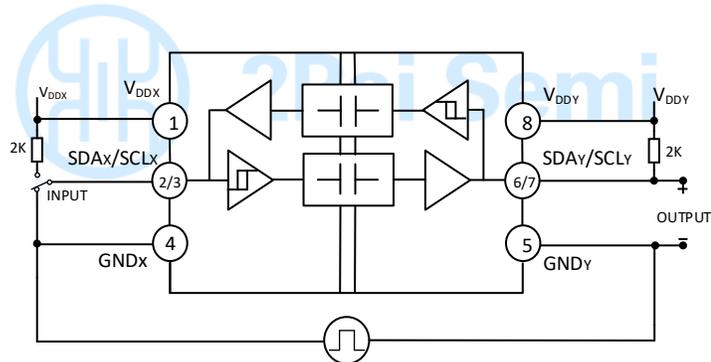


Figure 19. Common-Mode Transient Immunity Test Circuit

APPLICATIONS INFORMATION

Overview

The inter-integrated circuit (I²C) bus is a single-ended, two wire bus for efficient inter-IC communication and is used in a wide range of applications. The I²C bus is used for communication between multiple masters or a single master and slaves. The master device controls the serial clock line (SCL) and data is bidirectional transferred on the serial data line (SDA) between master and slaves. The I²C bus can theoretically add up to 112 communication nodes, however, the number of nodes will increase the load capacitance on the bus, thereby limiting the communication distances and communication speeds. In applications, tradeoffs are often made between communication speeds, bus length, and number of nodes based on actual conditions.

The I²C bus supports data transmission in four speeds: standard mode (up to 100Kbps), fast mode (up to 400Kbps), fast mode plus (up to 1Mbps), and high-speed mode (up to 3.4Mbps). The $\pi 220N31/\pi 221N31$ devices support all the above four communication modes.

FUNCTIONAL DESCRIPTION

The $\pi 220N31/\pi 221N31$ devices are low-power bidirectional isolators compatible with the I²C interface and are based on iDivider technology from 2PaiSemi. These devices have logic input and output buffers that are separated by using a silicon dioxide (SiO₂) barrier. These devices block high voltages and prevent noise currents from entering the control side ground, avoiding circuit interference and damaging sensitive components. Each channel output of the $\pi 220N31/\pi 221N31$ devices is made open-drain to comply with the open-drain technology of I²C. Serial data line (SDA) and serial clock line (SCL) need to add pull-up resistors to ensure normal operation of the system. It is recommended that side 1 of the I²C isolator be connected to the processor and sides 2 to the bus when there are multiple nodes on the I²C bus as side 2 support up to 400 pF capacitance load.

The $\pi 220N31/\pi 221N31$ devices feature two bidirectional channels that have open-drain outputs, As shown in Figure 20. As a logic low on one side causes the corresponding pin on the other side to be pulled low, to avoid data-latching within the device, The output logic low (VOL1) voltages of SDA1 and SCL1 are at least 60mV higher than the input threshold high (VIHT1) of SDA1 and SCL1, As shown in Figure 21.

Because the Side 2 logic levels/thresholds are standard I²C values, multiple $\pi 220N31/\pi 221N31$ devices connected to a bus by their Side 2 pins can communicate with each other and with other I²C compatible devices. However, because the Side 1 pin has a modified output level/ input threshold, this side of the $\pi 220N31/\pi 221N31$ can communicate only with devices that conform to the I²C standard.

The output low voltages of $\pi 220N31/\pi 221N31$ devices are guaranteed for sink currents of up to 35mA for side 2, and 3.5mA for side 1.

To enhance system reliability, it is recommended to connect the node with larger load capacitance and longer wires on side 2 for point-to-point communication.

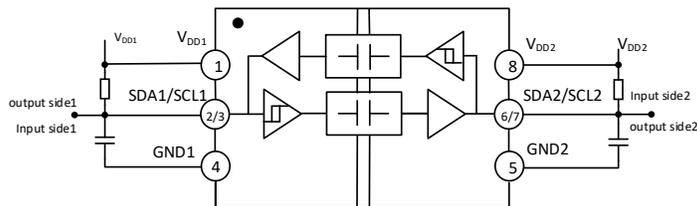


Figure 20. $\pi 220N31$ system operation diagram

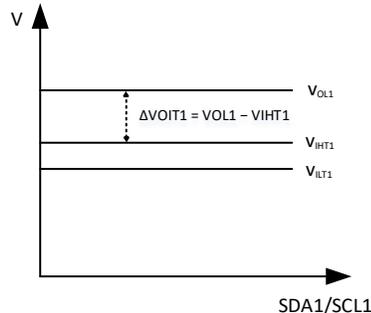


Figure 21. $\pi 220N31/\pi 221N31$ side 1 voltage Diagram

TYPICAL APPLICATION DIAGRAM

Figure 22 shows a typical application circuit including the pull-up resistors required for both Side 1 and Side 2. Bypass capacitors with values from 0.1 μ F to 10 μ F are required between V_{DD1} and GND1 and between V_{DD2} and GND2. To enhance the robustness of a design, the user may connect a resistor (50-200 Ω) in series between R2 and C1 and between R3 and C2 if the system is excessively noisy.

The $\pi 220N31/\pi 221N31$ are designed for operation at speeds up to 2 MHz. Due to the limited current available on side 1 and side2, operation at 2MHz limits the capacitance that can be driven at the minimum pull-up value to 40pF and 400pF.

Most applications operate at 100 kbps in standard mode or 400 kbps in fast mode. At these lower operating speeds, the limitation on the load capacitance can be significantly relaxed. If larger values for the pull up resistor are used, the maximum supported capacitance must be scaled down proportionately so that the rise time does not increase beyond the values required by the standard.

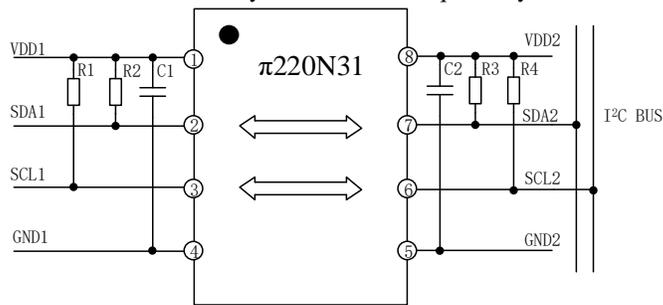


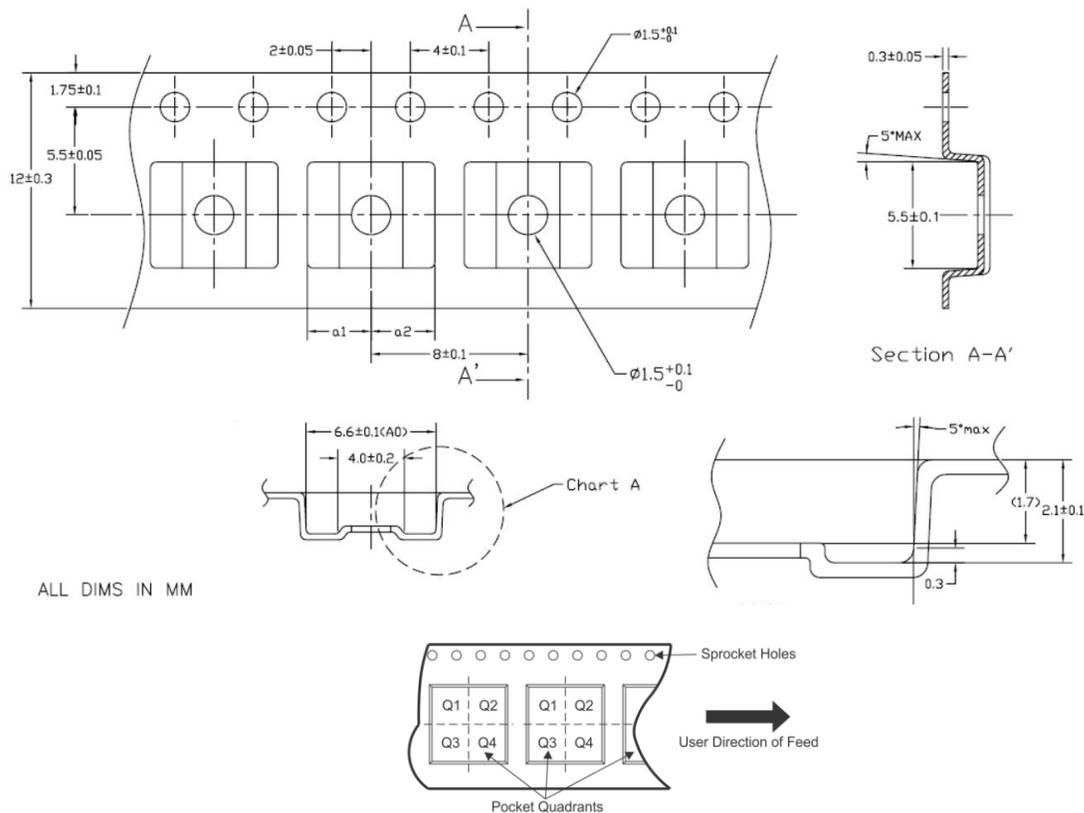
Figure 22. Typical Isolated I²C Interface Using the $\pi 220N31$

Top Marking



Line 1	π 1xxxxxx=Product name
Line 2	YY = Work Year WW = Work Week ZZ=Manufacturing code from assembly house
Line 3	XXXX, no special meaning

REEL INFORMATION



ALL DIMS IN MM

Note: The Pin 1 of the chip is in the quadrant Q1

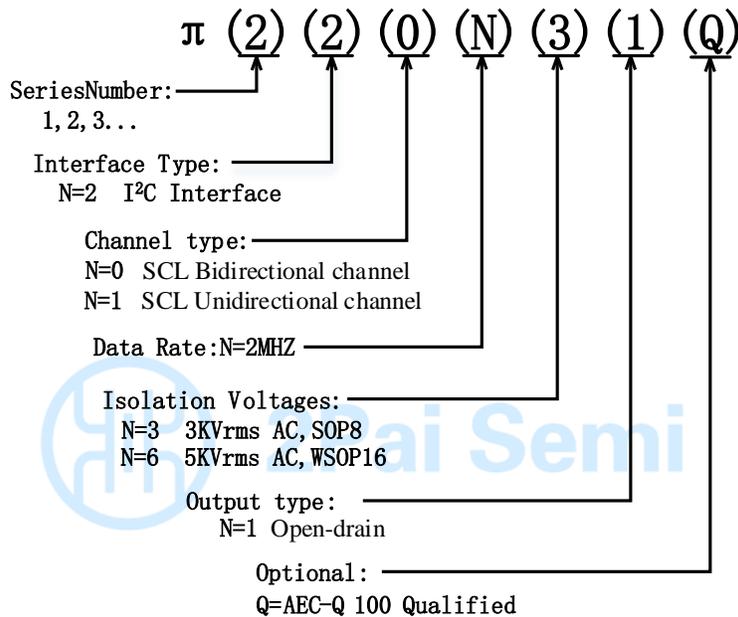
ORDERING GUIDE

Model Name ¹		Temperature Range	No. of Inputs, V _{DD1} Side	No. of Inputs, V _{DD2} Side	Withstand Voltage Rating (kV rms)	Maximum Data Rate (MHZ)	Package Description	MSL Peak Temp ²	Quantity per ree
π 220N31	Pai220N31	-40°C to +125°C	2	2	3	2	NB SOIC-8	Level-3-260C-168 HR	4000
π 221N31	Pai221N31	-40°C to +125°C	2	1	3	2	NB SOIC-8	Level-3-260C-168 HR	4000

Note:

¹ Pai2xxxx equals to π 2xxxx in the customer BOM² MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

PART NUMBER NAMED RULE



Notes:

Pai2xxxx equals to π 2xxxx in the customer BOM

IMPORTANT NOTICE AND DISCLAIMER

2Pai semi intends to provide customers with the latest, accurate, and in-depth documentation. However, no responsibility is assumed by 2Pai semi for its use, nor for any infringements of patents or other rights of third parties that may result from its use. Characterization data, available modules, and "Typical" parameters provided can and do vary in different applications. Application examples described herein are for illustrative purposes only. 2Pai semi reserves the right to make changes without further notice and limitation to product information, specifications, and descriptions herein, and does not give warranties as to the accuracy or completeness of the included information. 2Pai semi shall have no liability for the consequences of use of the information supplied herein.

Trademarks and registered trademarks are the property of their respective owners. This document does not imply, or express copyright licenses granted hereunder to design or fabricate any integrated circuits.

Room 308-309, No.22, Boxia Road, Pudong New District, Shanghai, 201203, China 021-50850681

2Pai Semiconductor Co., Limited. All rights reserved.

<http://www.rpsemi.com/>

REVISION HISTORY

Revision	Updated	Date	Page	Change Record
1	Devin	2020/02/24	All	Initial version